

Continental Device India Limited

An ISO/TS16949 and ISO 9001 Certified Company



SOT-23 Formed SMD Package

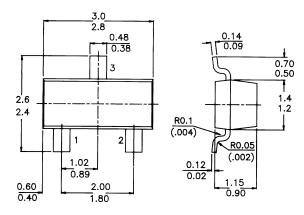
CMBT3905

SILICON EPITAXIAL TRANSISTOR

P-N-P transistor

Marking CMBT3905 = 2Y

PACKAGE OUTLINE DETAILS
ALL DIMENSIONS IN mm



Pin configuration

1 = BASE

2 = EMITTER

3 = COLLECTOR



ABSOLUTE MAXIMUM RATINGS

Collector-base voltage (open emitter)	$-V_{CBO}$	max.	40	V
Collector-emitter voltage (open base)	$-V_{CEO}$	max.	40	V
Emitter-base voltage (open collector)	$-V_{EBO}$	max.	5	V
Collector current (d.c.)	$-I_C$	max.	<i>200</i>	mΑ
Total power dissipation up to $T_{amb} = 60 ^{\circ}C$	P_{tot}	max.	<i>250</i>	mW
D.C. current gain				
$-I_C = 10 \text{ mA; } -V_{CE} = 1 \text{ V}$	h_{FE}	50 to	150	
Transition frequency at $f = 100 \text{ MHz}$				
$-I_C = 10 \text{ mA; } -V_{CE} = 20 \text{ V}$	f_T	min.	<i>200</i>	MHz

CMBT3905

DATINGS (at T. 95°C unless atherwise specified)			
RATINGS (at $T_A = 25^{\circ}C$ unless otherwise specified) Limiting values			
Collector-base voltage (open emitter)	$-V_{CB0}$	max.	40 V
Collector-emitter voltage (open base)	$-V_{CE0}$	max.	40 V
Emitter-base voltage (open collector)	$-V_{EB0}$	max.	5 V
Collector current (d.c.)	$-I_C$	max.	200 mA
Total power dissipation*			
$up to T_{amb} = 25 ^{\circ}C$	P_{tot}	max.	250~mW
Storage temperature	T_{stg}	-55 to	+150 °C
THERMAL CHARACTERISTICS			
$T_{j} = P(R_{th j-t} + R_{th t-s} + R_{th s-a}) + T_{amb}$			
Thermal resistance			
from junction to ambient	$R_{th\ j-a}$	=	<i>200</i> ℃W
CHARACTERISTICS (at $T_A = 25^{\circ}C$ unless otherwise specifications)	fied)		
T_{amb} = 25 °C unless otherwise specified			
Collector-emitter breakdown voltage			
$-I_C = 1 \text{ mA; } l_B = 0$	−V(BR)CE0	min.	40 V
Collector-base breakdown voltage			
$-I_C = 10\mu A; I_E = 0$	$-V_{(BR)CB0}$	min.	40 V
Emitter-base breakdown voltage	17		<i>r</i> 17
$-I_E = 10 \mu A; I_C = 0$ Collector cut-off current	$-V_{(BR)EB0}$	mın.	5 V
$-V_{CE} = 30 \text{ V}; -V_{EB} = 3 \text{ V}$	-I _{CEX}	max.	50 nA
Base current	-ICEX	max.	JU 1121
with reverse biased emitter junction	$-I_{BEX}$	max.	50 nA
Output capacitance at $f = 100 \text{ kHz}$	-DLA		
$I_E = 0$; $-V_{CB} = 5 V$	C_{c}	max.	4.5 pF
Input capacitance at $f = 100 \text{ kHz}$	· ·		•
$I_C = 0; -V_{BE} = 0.5 V$	C_e	max.	10 pF
Saturation voltages			
$-I_C = 10 \text{ mA}; -I_B = 1 \text{ mA}$	-V _{CEsat}	max.	0,25 V
$-I_C = 50 \text{ mA; } -I_B = 5 \text{ mA}$	-V _{CEsat}	max.	0,4 V
$-I_C = 10 \text{ mA}; -I_B = 1 \text{ mA}$	-V _{BEsat}	min.	0,65 V
		max.	0,85 V
$-I_C = 50$ mA; $-I_B = 5$ mA	-V _{BEsat}	max.	0,95 V
D.C. current gain			
$-I_C = 0.1 \text{ mA; } -V_{CE} = 1 \text{ V}$	h_{FE}	min.	30
$-I_C = 1 \text{ mA; } -V_{CE} = 1 \text{ V}$	h_{FE}	min.	40
$-I_C = 10 \text{ mA; } -V_{CE} = 1 \text{ V}$	h_{FE}	min.	50
		max.	150

$-I_C = 50 \text{ mA; } -V_{CE} = 1 \text{ V}$	$h_{\!F\!E}$	min.	30
$-I_C = 100 \text{ mA; } -V_{CE} = 1 \text{ V}$	$h_{\!F\!E}$	min.	15
Transition frequency at $f = 100 \text{ MHz}$			
$-I_C = 10mA; -V_{CE} = 20V$	f_T	min.	200 MHz
Noise figure at $R_S = 1 k\Omega$			
$-I_C = 100 \mu A; -V_{CE} = 5 V$			
f = 10 Hz to 15.7 kHz	F	max.	4 dB
Small Signal Current Gain			
$-V_{CE} = 10V$; $-I_{C} = 1$ mA; $f = 1$ KHz	h_{fe}	min.	<i>50</i>
		max.	200

Disclaimer

The product information and the selection guides facilitate selection of the CDIL's Discrete Semiconductor Device(s) best suited for application in your product(s) as per your requirement. It is recommended that you completely review our Data Sheet(s) so as to confirm that the Device(s) meet functionality parameters for your application. The information furnished on the CDIL Web Site/CD are believed to be accurate and reliable. CDIL however, does not assume responsibility for inaccuracies or incomplete information. Furthermore, CDIL does not assume liability whatsoever, arising out of the application or use of any CDIL product; neither does it convey any license under its patent rights nor rights of others. These products are not designed for use in life saving/support appliances or systems. CDIL customers selling these products (either as individual Discrete Semiconductor Devices or incorporated in their end products), in any life saving/support appliances or systems or applications do so at their own risk and CDIL will not be responsible for any damages resulting from such sale(s).

CDIL strives for continuous improvement and reserves the right to change the specifications of its products without prior notice.



CDIL is a registered Trademark of

Continental Device India Limited

C-120 Naraina Industrial Area, New Delhi 110 028, India.

Telephone + 91-11-2579 6150, 5141 1112 Fax + 91-11-2579 5290, 5141 1119

email@cdil.com www.cdilsemi.com